

Features

- Optimized package with separate driver source pin
- High blocking voltage with low on-resistance
- High-speed switching with low capacitances
- Fast intrinsic diode with low reverse recovery (Q_{rr})
- Halogen free, RoHS compliant

Benefits

- Reduce switching losses and minimize gate ringing
- Higher system efficiency
- Reduce cooling requirements
- Increase power density
- Increase system switching frequency

Applications

- Solar inverters
- EV motor drive
- High voltage DC/DC converters
- Switched mode power supplies
- Load switch

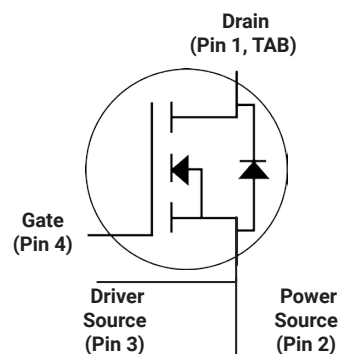
Part Number	Package	Marking
GC3M0021120K	TO-247-4	GC3M0021120

V_{DS}	1200 V
I_D @ 25°C	100 A
$R_{DS(on)}$	21 mΩ



TO-247-4

Package



Maximum Ratings ($T_C = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions	Note
V_{DSmax}	Drain - Source Voltage	1200	V	$V_{GS} = 0\text{ V}, I_D = 100\text{ }\mu\text{A}$	
V_{GSmax}	Gate - Source Voltage (dynamic)	-8/+19	V	AC ($f > 1\text{ Hz}$)	Note 1
V_{GSop}	Gate - Source Voltage (static)	-4/+15	V	Static	Note 2
I_D	Continuous Drain Current	100	A	$V_{GS} = 15\text{ V}, T_C = 25^\circ\text{C}$	Fig. 19
		74		$V_{GS} = 15\text{ V}, T_C = 100^\circ\text{C}$	
$I_{D(pulse)}$	Pulsed Drain Current	200	A	Pulse width t_p limited by T_{jmax}	
P_D	Power Dissipation	469	W	$T_C = 25^\circ\text{C}, T_J = 175^\circ\text{C}$	Fig. 20
T_J, T_{stg}	Operating Junction and Storage Temperature	-40 to +175	°C		
T_L	Solder Temperature	260	°C	1.6mm (0.063") from case for 10s	

Note (1): When using MOSFET Body Diode $V_{GSmax} = -4\text{V}/+19\text{V}$

Note (2): MOSFET can also safely operate at 0/+15 V

**SUPSiC®****Electrical Characteristics** ($T_c = 25^\circ\text{C}$ unless otherwise specified)无锡国晶微半导体技术有限公司
Wuxi Gwok Semiconductor Co.,Ltd**GC3M0021120K**
Silicon Carbide Power MOSFET
N-Channel Enhancement Mode

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	1200			V	$V_{GS} = 0\text{ V}, I_D = 100\text{ }\mu\text{A}$	
$V_{GS(th)}$	Gate Threshold Voltage	1.8	2.5	3.6	V	$V_{DS} = V_{GS}, I_D = 17.7\text{ mA}$	Fig. 11
			2.0		V	$V_{DS} = V_{GS}, I_D = 17.7\text{ mA}, T_J = 175^\circ\text{C}$	
I_{DSS}	Zero Gate Voltage Drain Current		1	50	μA	$V_{DS} = 1200\text{ V}, V_{GS} = 0\text{ V}$	
I_{GSS}	Gate-Source Leakage Current		10	250	nA	$V_{GS} = 15\text{ V}, V_{DS} = 0\text{ V}$	
$R_{DS(on)}$	Drain-Source On-State Resistance		21	28.8	m Ω	$V_{GS} = 15\text{ V}, I_D = 50\text{ A}$	Fig. 4, 5, 6
			38			$V_{GS} = 15\text{ V}, I_D = 50\text{ A}, T_J = 175^\circ\text{C}$	
g_{fs}	Transconductance		35		S	$V_{DS} = 20\text{ V}, I_{DS} = 50\text{ A}$	Fig. 7
			33			$V_{DS} = 20\text{ V}, I_{DS} = 50\text{ A}, T_J = 175^\circ\text{C}$	
C_{iss}	Input Capacitance		4818		pF	$V_{GS} = 0\text{ V}, V_{DS} = 1000\text{ V}$ $f = 1\text{ MHz}$ $V_{AC} = 25\text{ mV}$	Fig. 17, 18
C_{oss}	Output Capacitance		180				
C_{rss}	Reverse Transfer Capacitance		12				
E_{oss}	C_{oss} Stored Energy		99		μJ		Fig. 16
E_{ON}	Turn-On Switching Energy (SiC Diode FWD)		0.69		mJ	$V_{DS} = 800\text{ V}, V_{GS} = -4\text{ V}/+15\text{ V}, I_D = 50\text{ A},$ $R_{G(ext)} = 2.5\Omega, L = 157\text{ }\mu\text{H}, T_J = 175^\circ\text{C}$	Fig. 26, 29
E_{OFF}	Turn Off Switching Energy (SiC Diode FWD)		0.42				
E_{ON}	Turn-On Switching Energy (Body Diode FWD)		1.58		mJ	$V_{DS} = 800\text{ V}, V_{GS} = -4\text{ V}/+15\text{ V}, I_D = 50\text{ A},$ $R_{G(ext)} = 2.5\Omega, L = 157\text{ }\mu\text{H}, T_J = 175^\circ\text{C}$	Fig. 26, 29
E_{OFF}	Turn Off Switching Energy (Body Diode FWD)		0.34				
$t_{d(on)}$	Turn-On Delay Time		29		ns	$V_{DD} = 800\text{ V}, V_{GS} = -4\text{ V}/15\text{ V}$ $R_{G(ext)} = 2.5\Omega,$ $L = 157\text{ }\mu\text{H}$	Fig. 27
t_r	Rise Time		33				
$t_{d(off)}$	Turn-Off Delay Time		57				
t_f	Fall Time		14				
$R_{G(int)}$	Internal Gate Resistance		3.3		Ω	$f = 1\text{ MHz}, V_{AC} = 25\text{ mV}$	
Q_{gs}	Gate to Source Charge		49		nC	$V_{DS} = 800\text{ V}, V_{GS} = -4\text{ V}/15\text{ V}$ $I_D = 50\text{ A}$ Per IEC60747-8-4 pg 21	Fig. 12
Q_{gd}	Gate to Drain Charge		50				
Q_g	Total Gate Charge		162				

Reverse Diode Characteristics ($T_c = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
V_{SD}	Diode Forward Voltage	4.6		V	$V_{GS} = -4\text{ V}, I_{SD} = 25\text{ A}, T_J = 25^\circ\text{C}$	Fig. 8, 9, 10
		4.2		V	$V_{GS} = -4\text{ V}, I_{SD} = 25\text{ A}, T_J = 175^\circ\text{C}$	
I_S	Continuous Diode Forward Current		90	A	$V_{GS} = -4\text{ V}, T_c = 25^\circ\text{C}$	Note 1
$I_{S, pulse}$	Diode pulse Current		200	A	$V_{GS} = -4\text{ V},$ pulse width t_p limited by T_{jmax}	Note 1
t_{rr}	Reverse Recover time	34		ns	$V_{GS} = -4\text{ V}, I_{SD} = 50\text{ A}, V_R = 800\text{ V}$ $\text{dif}/\text{dt} = 2600\text{ A}/\mu\text{s}, T_J = 175^\circ\text{C}$	Note 1
Q_{rr}	Reverse Recovery Charge	928		nC		
I_{rrm}	Peak Reverse Recovery Current	42		A		

Thermal Characteristics

Symbol	Parameter	Typ.	Unit	Test Conditions	Note
$R_{\theta JC}$	Thermal Resistance from Junction to Case	0.32	$^\circ\text{C}/\text{W}$		Fig. 21
$R_{\theta JA}$	Thermal Resistance From Junction to Ambient	40			

Typical Performance

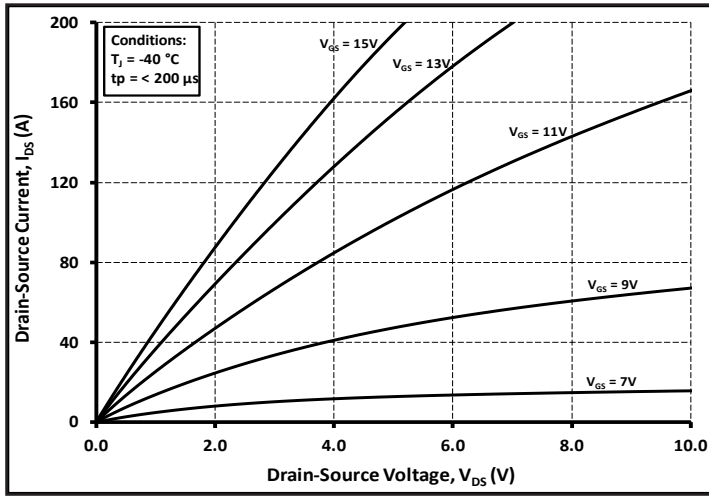


Figure 1. Output Characteristics $T_J = -40\text{ }^{\circ}\text{C}$

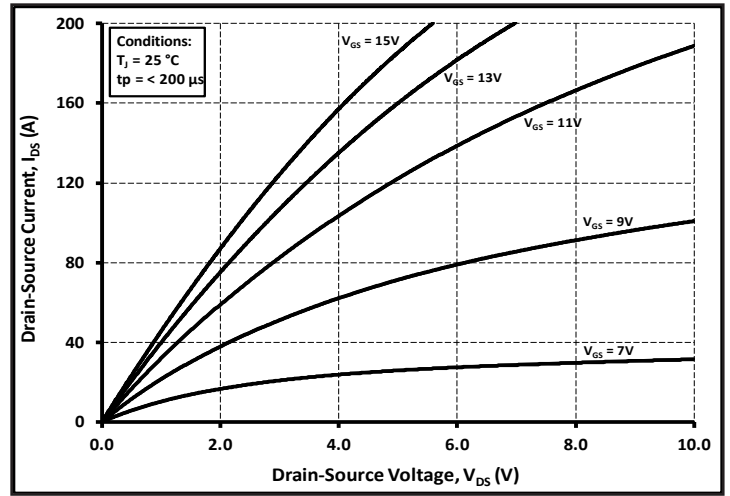


Figure 2. Output Characteristics $T_J = 25\text{ }^{\circ}\text{C}$

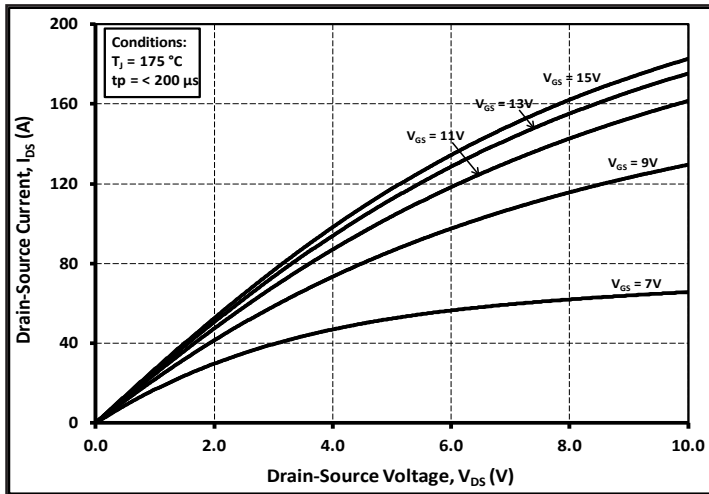


Figure 3. Output Characteristics $T_J = 175\text{ }^{\circ}\text{C}$

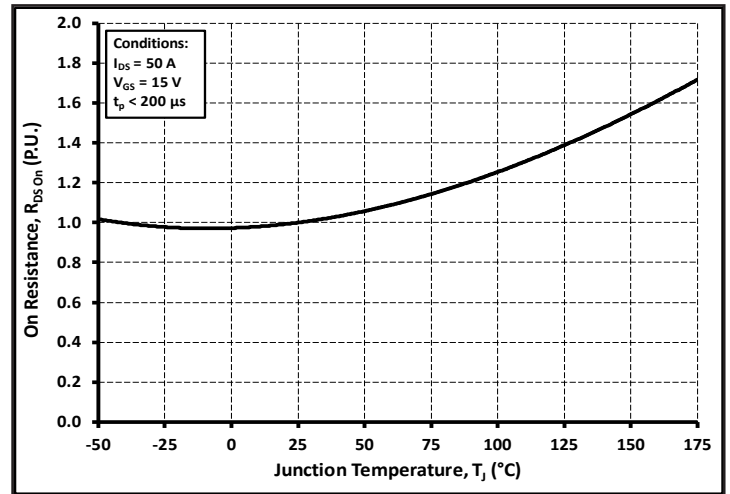


Figure 4. Normalized On-Resistance vs. Temperature

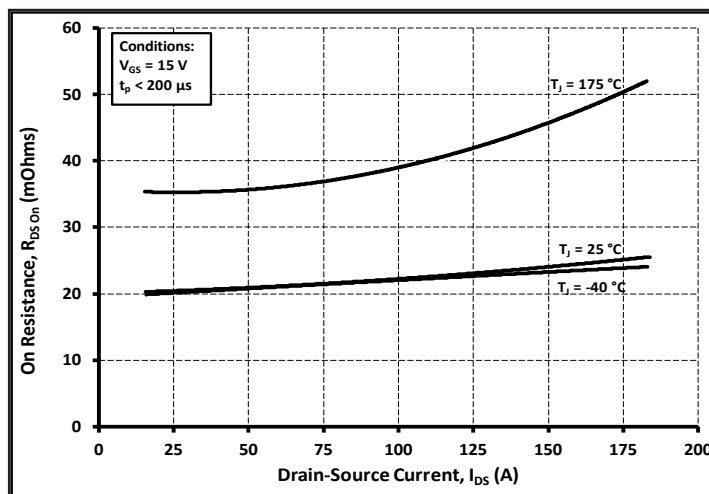


Figure 5. On-Resistance vs. Drain Current
For Various Temperatures

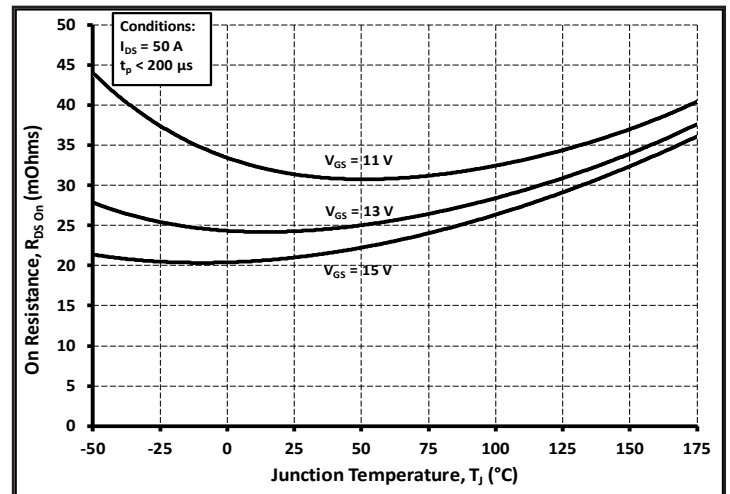


Figure 6. On-Resistance vs. Temperature
For Various Gate Voltage

Typical Performance

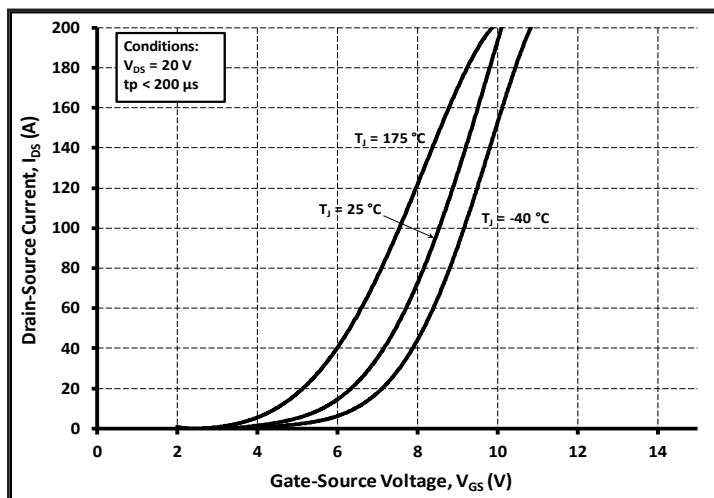


Figure 7. Transfer Characteristic for Various Junction Temperatures

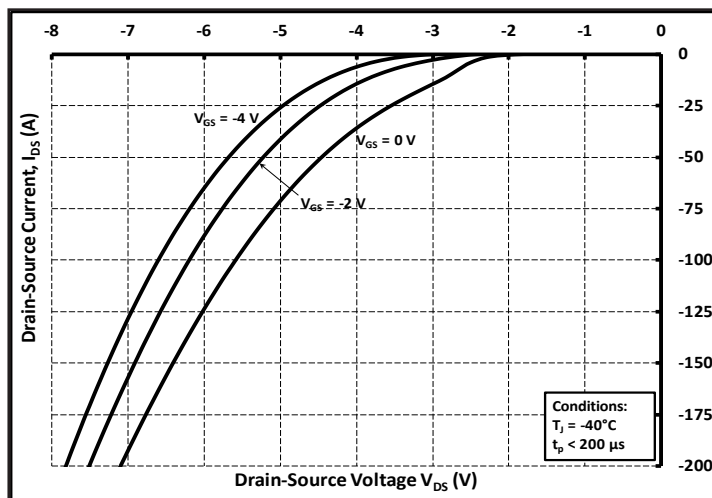


Figure 8. Body Diode Characteristic at -40 °C

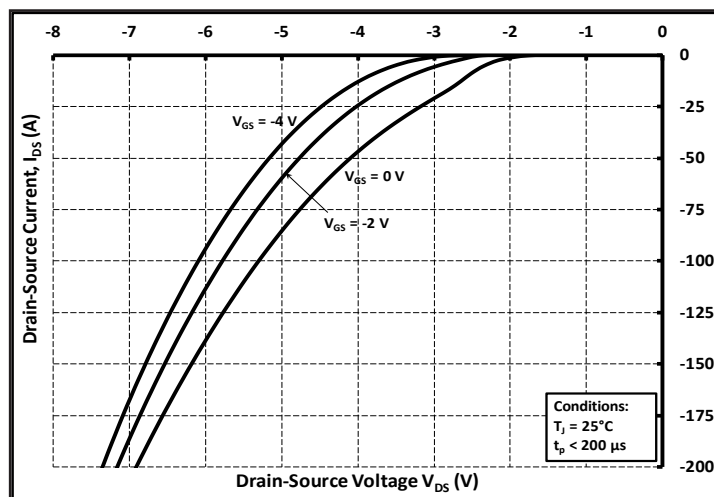


Figure 9. Body Diode Characteristic at 25 °C

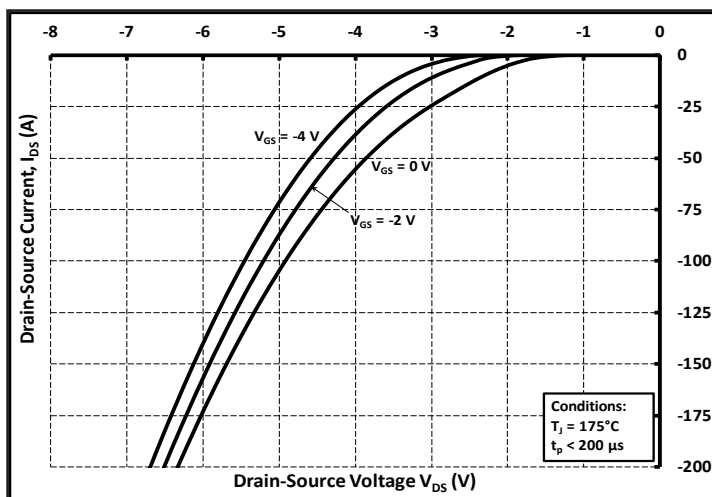


Figure 10. Body Diode Characteristic at 175 °C

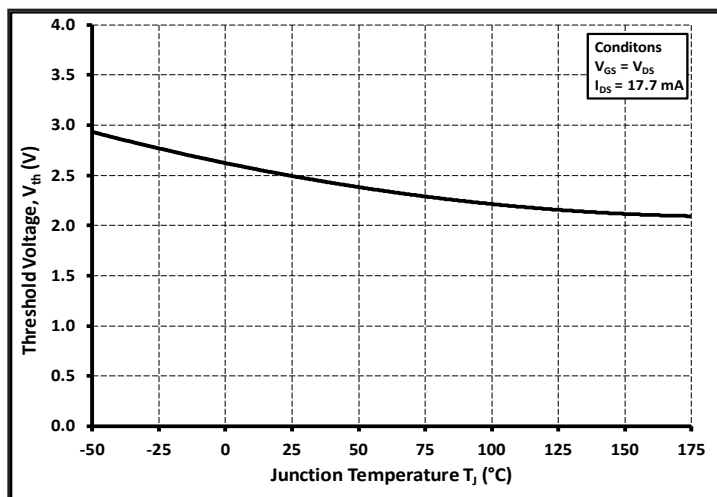


Figure 11. Threshold Voltage vs. Temperature

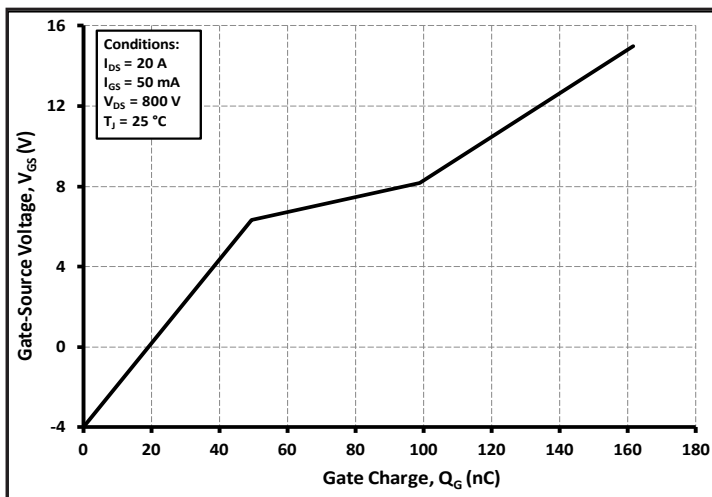


Figure 12. Gate Charge Characteristics

Typical Performance

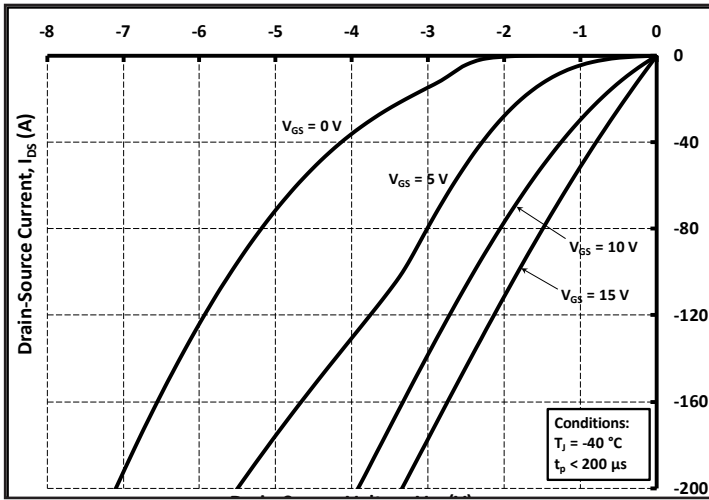


Figure 13. 3rd Quadrant Characteristic at -40 °C

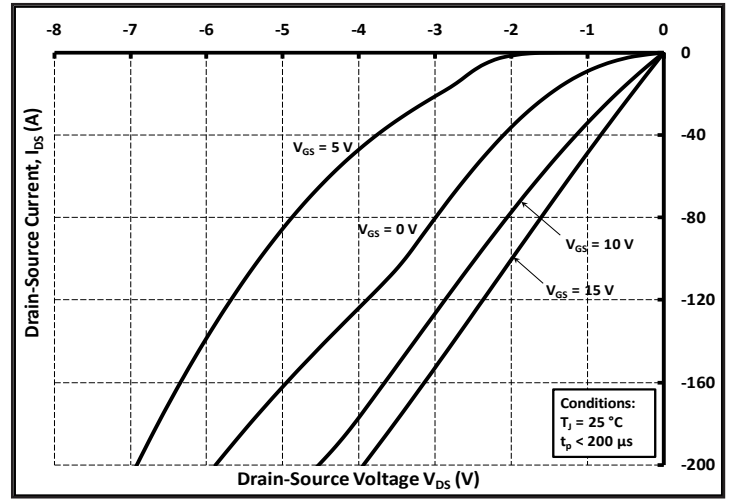


Figure 14. 3rd Quadrant Characteristic at 25 °C

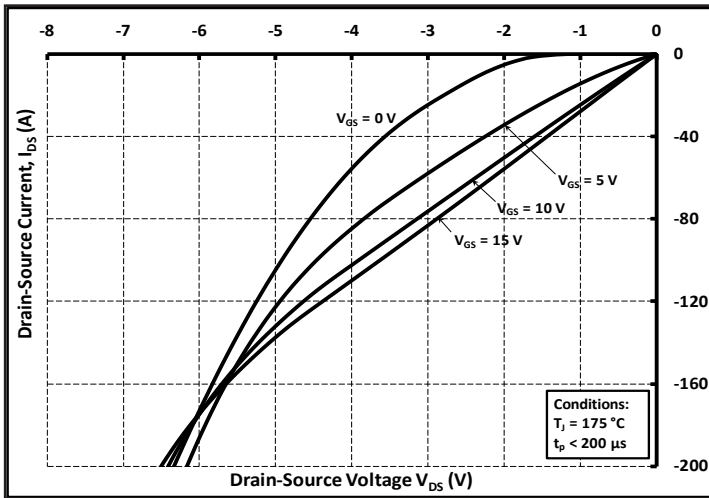


Figure 15. 3rd Quadrant Characteristic at 175 °C

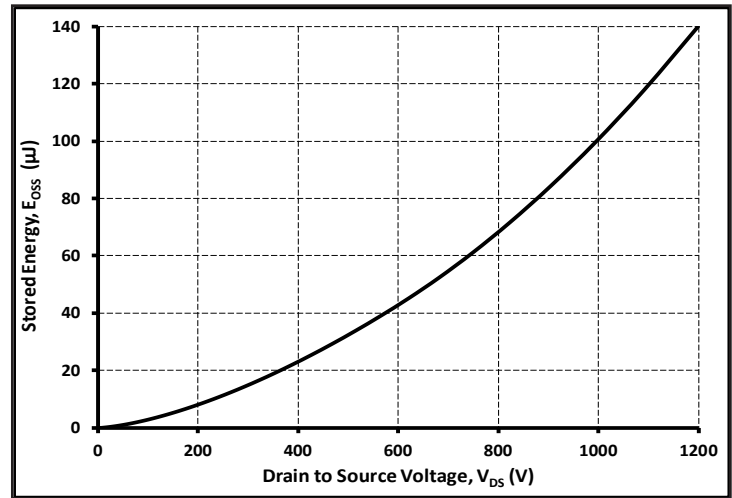


Figure 16. Output Capacitor Stored Energy

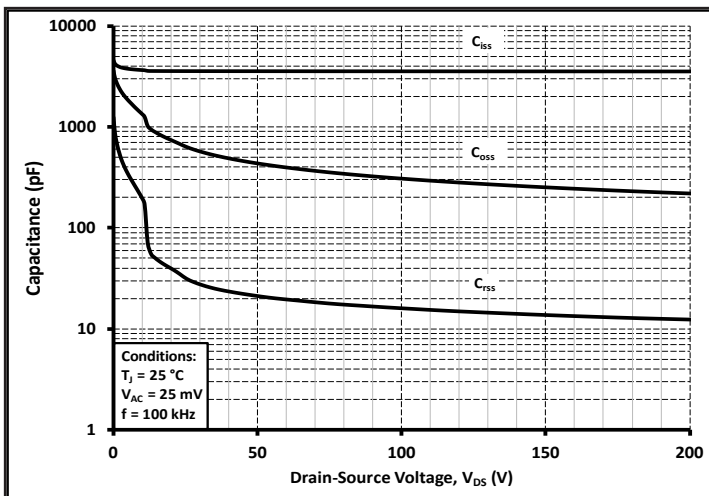


Figure 17. Capacitances vs. Drain-Source Voltage (0 - 200V)

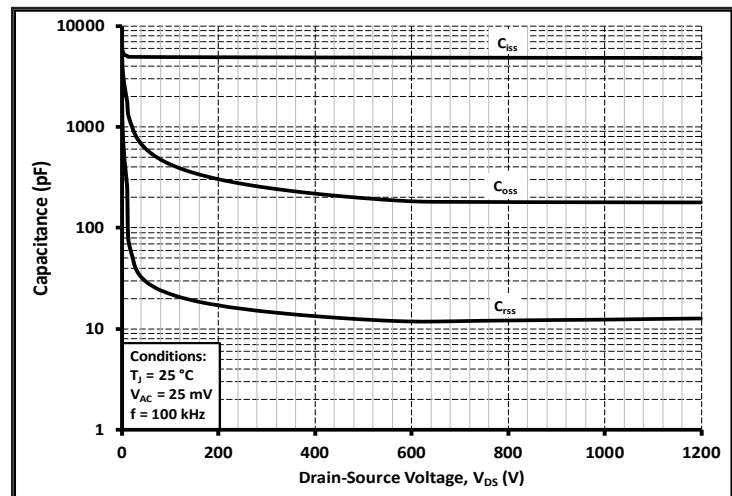


Figure 18. Capacitances vs. Drain-Source Voltage (0 - 1000V)

Typical Performance

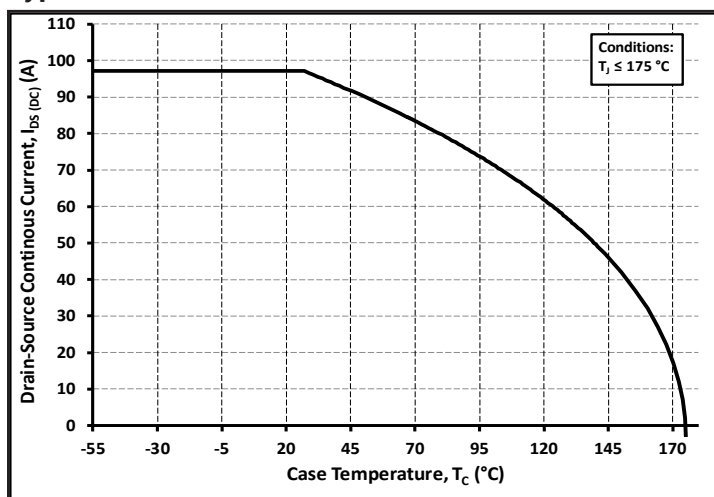


Figure 19. Continuous Drain Current Derating vs. Case Temperature

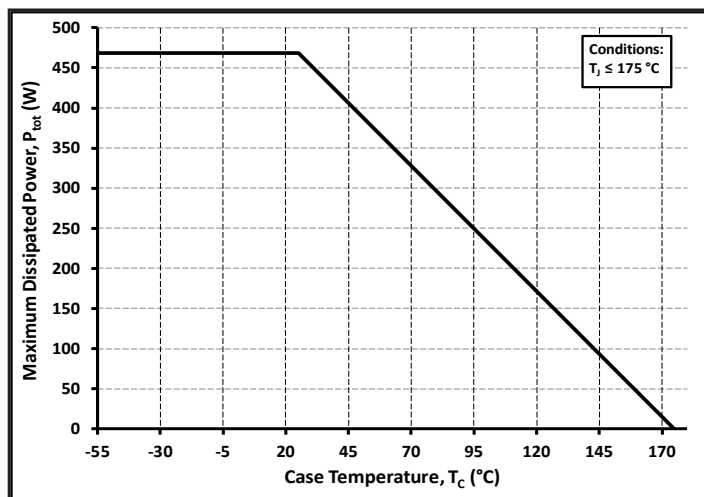


Figure 20. Maximum Power Dissipation Derating vs. Case Temperature

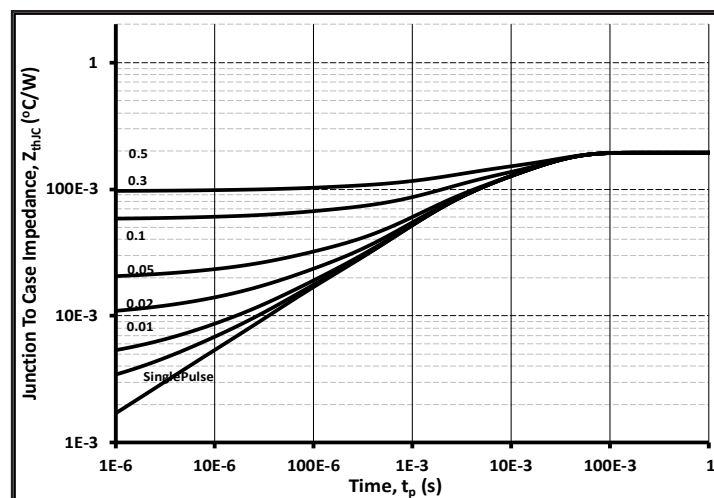


Figure 21. Transient Thermal Impedance (Junction - Case)

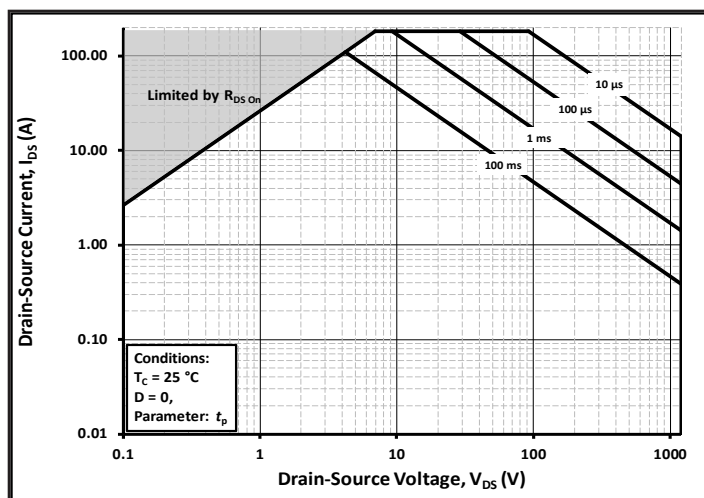


Figure 22. Safe Operating Area

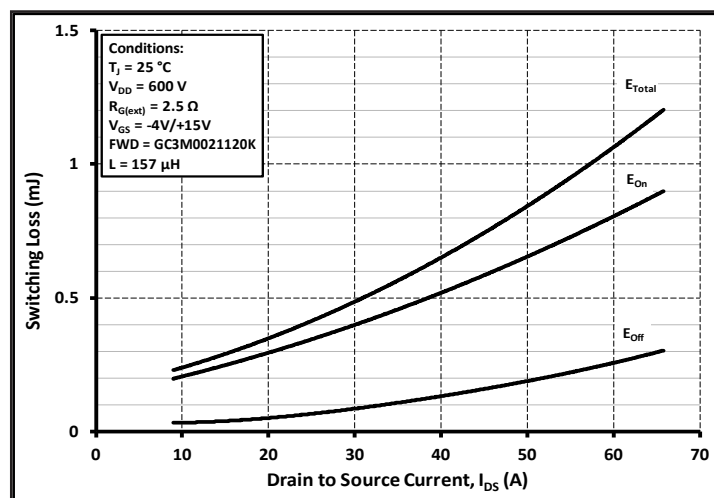


Figure 23. Clamped Inductive Switching Energy vs. Drain Current ($V_{DD} = 600V$)

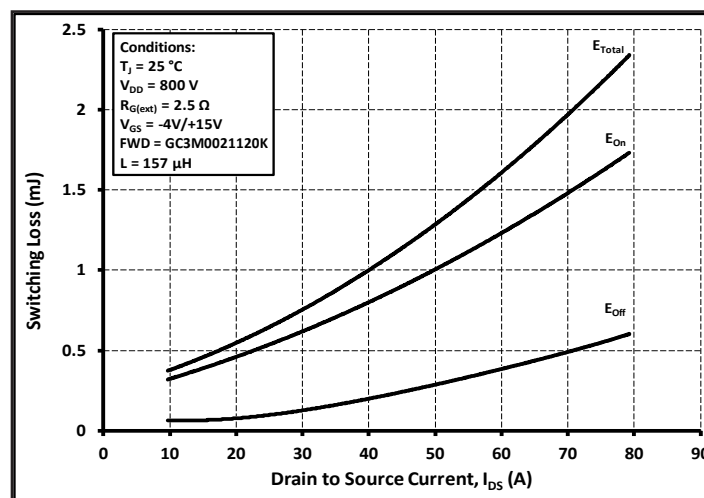


Figure 24. Clamped Inductive Switching Energy vs. Drain Current ($V_{DD} = 800V$)

Typical Performance

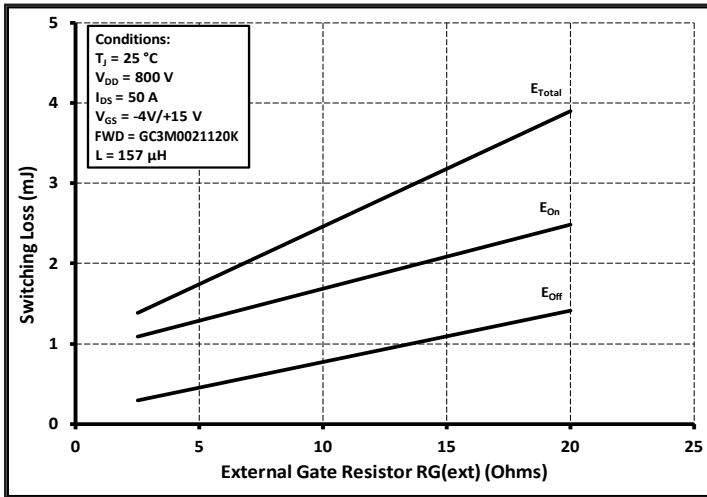


Figure 25. Clamped Inductive Switching Energy vs. $R_{G(ext)}$

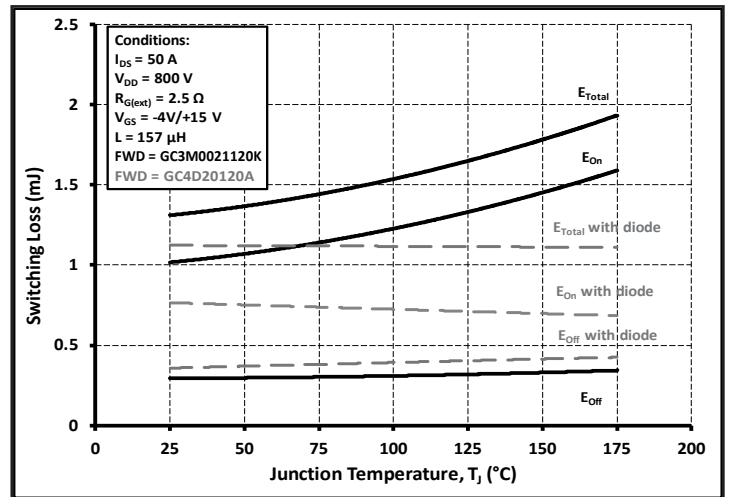


Figure 26. Clamped Inductive Switching Energy vs. Temperature

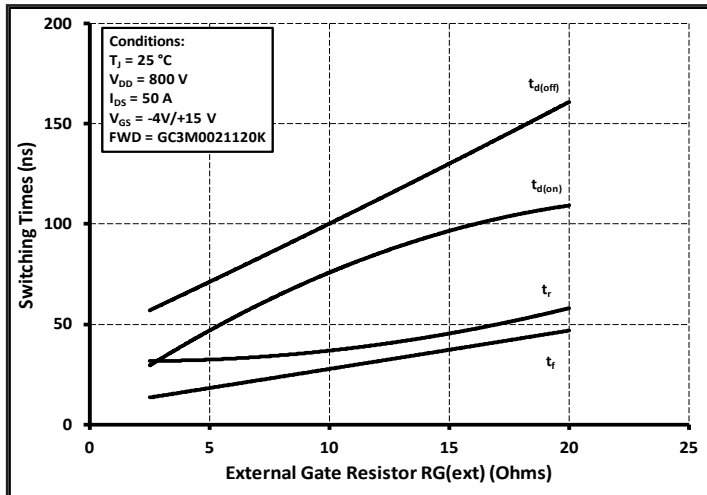


Figure 27. Switching Times vs. $R_{G(ext)}$

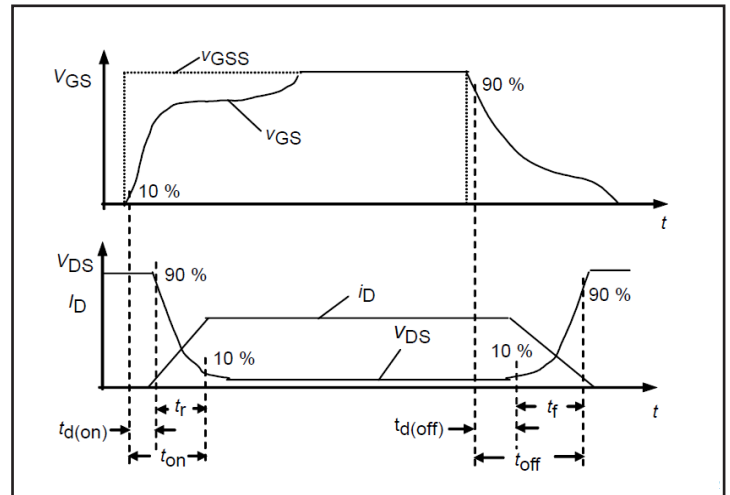


Figure 28. Switching Times Definition

Test Circuit Schematic

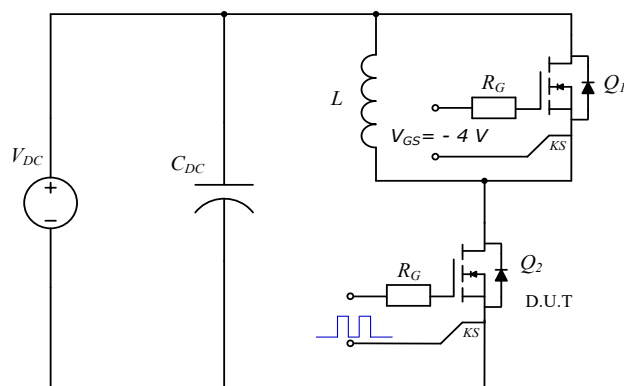
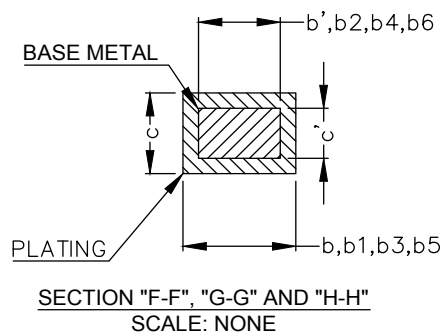
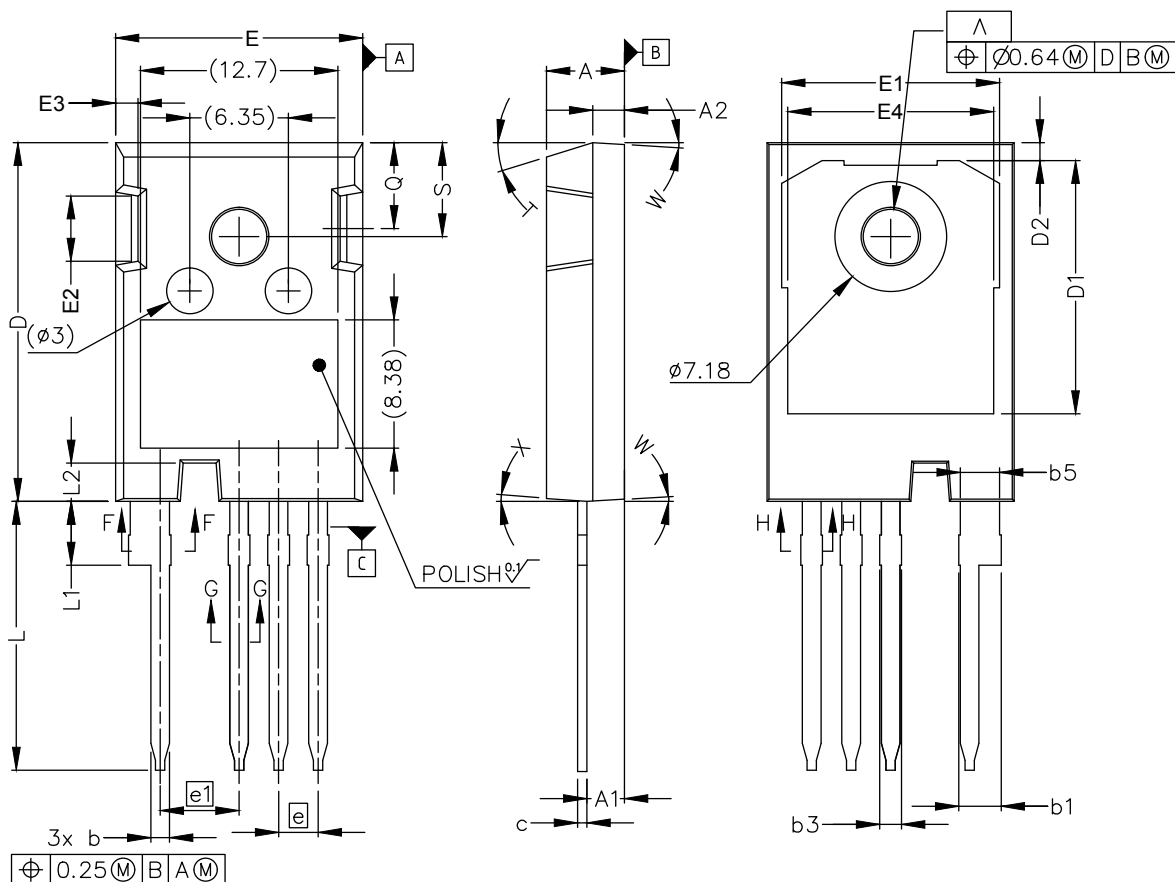


Figure 29. Clamped Inductive Switching
Waveform Test Circuit

Note (3): Turn-off and Turn-on switching energy and timing values measured using SiC MOSFET Body Diode as shown above.

Package Dimensions

Package TO-247-4L



Package Dimensions

Package TO-247-4L

SYM	MILLIMETERS		SYM	MILLIMETERS	
	MIN	MAX		MIN	MAX
A	4.83	5.21	E1	13.10	14.15
A1	2.29	2.54	E2	3.68	5.10
A2	1.91	2.16	E3	1.00	1.90
b'	1.07	1.28	E4	12.38	13.43
b	1.07	1.33	e	2.54 BSC	
b1	2.39	2.94	e1	5.08 BSC	
b2	2.39	2.84	N	4	
b3	1.07	1.60	L	17.31	17.82
b4	1.07	1.50	L1	3.97	4.37
b5	2.39	2.69	L2	2.35	2.65
b6	2.39	2.64	øP	3.51	3.65
c'	0.55	0.65	Q	5.49	6.00
c	0.55	0.68	S	6.04	6.30
D	23.30	23.60	T	17.5° REF.	
D1	16.25	17.65	W	3.5° REF.	
D2	0.95	1.25	X	4° REF.	
E	15.75	16.13			

Recommended Solder Pad Layout

